

ITEM :

CRYSTAL RESONATORS

DSX321G	26.000MHz
(JAPAN)	1B326000AB0AR
(INDONESIA)	1C326000AB0AR
(THA I LAND)	1N326000AB0AR

Please acknowledge receipt of this specificaiton by signing and returning a copy to us.

	RECEIPT
DATE	
RECEIVED	(signature) (name)

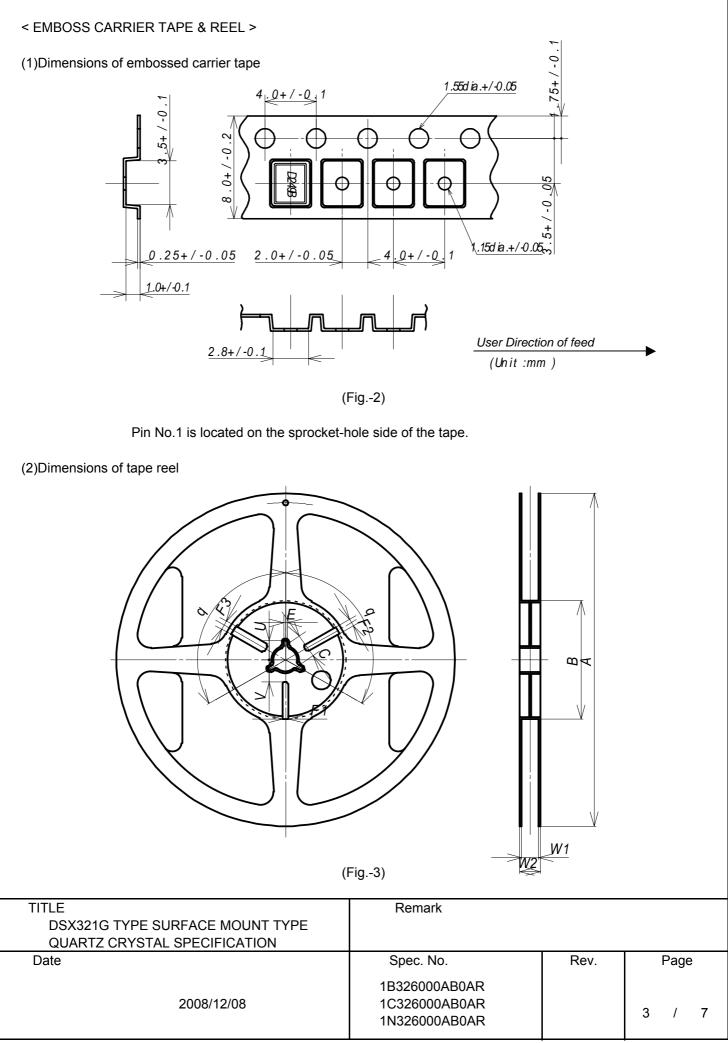


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1. ELECTRICAL CHARACTERISTICS (This test shall be performed under the conditions of temp.at $25 \pm 3^{\circ}$ C, humidity 60% max.)						
1-1	NOMINAL FREQUENCY	26.000000 MHz				
1-2	OVERTONE ORDER	Fundamental				
1-3	LOAD CAPACITANCE(CL)	19.0 pF				
1-4	FREQUENCY TOLERANCE	\pm 7 ppm max. at +25 °C \pm 3 °C				
1-5	DRIVE LEVEL	10 ± 2 μW (100 μW max.)				
1-6	SERIES RESISTANCE	50 Ω max. / Series				
1-7	OPERATING TEMPERATURE RANGE	-40 ~ +85 °C				
1-8	FREQUENCY CHARACTERISTICS OVER TEMPERATURE	± 15 ppm max. / -40 ~ +85 °C (ref. +25°C)				
1-9	SHUNT CAPACITANCE	2.0 pF max.				
1-10	INSULATION RESISTANCE	500 M Ω min. / DC100 ± 15V				
1-11	STORAGE TEMPERATURE RANGE	-40 ~ +85 °C				
1-12	AGING	 ± 1.0 ppm max. / 1 year. ± 1.5 ppm max. / 2 years. ± 5.0 ppm max. / 10 years. 				
1-13	.PULLING SENSITIVITY	5.0 ~ 11.0 ppm / pF at CL = 19 pF (typ.)				
2. CON	ISTRUCTION					
2-1	HOLDER	DSX321G Ceramic Base				
2-2	DIMENSIONS AND MARKING	Refer to Fig1 and Table-1.				
3. OTH	ER SPECIFICATIONS					
3-1	EMBOSS CARRIER TAPE & REEL	Refer to Fig2,3,4,5 and Table-2.				
3-2	PACKING	Refer to Fig6.				
3-3	REFLOW CONDITIONS (REFERENCE)	Refer to Fig7.				
3-4	LAND PATTERN (REFERENCE)	Refer to Fig8.				
4. Envi	ronmental and mechanical performance shall b	e specified by attached general specification.				
TI	OF FREON: his related product is not used with any ODC C					
QI	SX321G TYPE SURFACE MOUNT TYPE JARTZ CRYSTAL SPECIFICATION	Remark				
Date	2008/12/08	Spec. No.Rev.Page1B326000AB0AR1C326000AB0AR11N326000AB0AR1/				
	DAISHI	DAISHINKU CORP. DM-Z0002:Style-010				

< DIMEN	ISIONS A	ND MAR	KING >								
~		3.20			0.15						
	(1)((Logo Freq	,	3) - ⁶⁵ ° °	<u>∧</u>							
0.75 +/-0.15											
	<	2.10 0.30									
1.60	#1	# 2			< Top V	iew >					
	# 4	# 3_		# 4		f # 3 # 2					
Ļ	0.90										
It is re unit :	ecommende mm	d that #2,4 i	s connected	I with GND.							
	ance : ±-0.1				(Fig1)						
Mar Log	king is La king shou o , Nomin o(1), Noi	ld be prin al Freque	ited as fol ency , mai	nufacture	-		on				
	Proc	ducing Dis	strict	Our S	pecificatio	on.No.	(1) L	_ogo	(2) F	requency]
		Japan		1B32	26000AB	0AR	C)		26	
	I	ndonesia	a	1C3	26000AE	80AR	[<u>)</u>		26	
Non	ninal Freq	uency (2) = Mark	two diait	s from un	ner					
	(ex. 26.			-)	poi					
Mar) ufacturino (year)	g lot No.(ex.	3) 2008	shall be	, marked marked	as ' 8 as ' M	' (The l ' (As sl	last digit nown in ⁻	of the y	year) .)	
	/							·		,	
Jan.	Feb.	(Table-´ Mar.	1) Apr.	May.	Jun.	Jul.	Aug.	Sep.	Oct.	Nov.	Dec.
A	B	C	D	E	F	G	H H	J	K	L	M
TITLE						R	emark				
DSX	(321G TY ARTZ CR`				PE						
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DAISHINKU CORP.

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(Table-2)								
	(UNIT:mm)							
	Item		Mark	Dimensions Angle				
	Diamete	r	Α	180 Φ +0.0 / -3.0				
Elando	Inside of Fra	inge	W1	9.0 ± 0.3				
Flange	Outside of Fr	ange	W2	11.4 ± 1.0				
	Inside Diam	eter	В	60 Φ +1.0 / -0.0				
		Width	F1	3.0 ± 0.2				
			F2	4.0 ± 0.2				
	Center Core Slit		F3	5.0 ± 0.2				
Center		Length	V	11.9 +0.5 / -0.0				
Core		Angle	q	120°				
	Spindle Dian	neter	С	13 Φ ± 0.2				
		Width	E	2.0 ± 0.5				
	Key Seats	Length	U	10.5 ± 0.4				
		Angle	q	120°				

(3)Storage condition

Temperature : +40 °C max.

Relative Humidity : 80% max.

(It is a guaranteed term because it obtains an excellent soldering: 6 months)

(4)Standard packing quantity

3,000 pcs./reel for 180 Φ

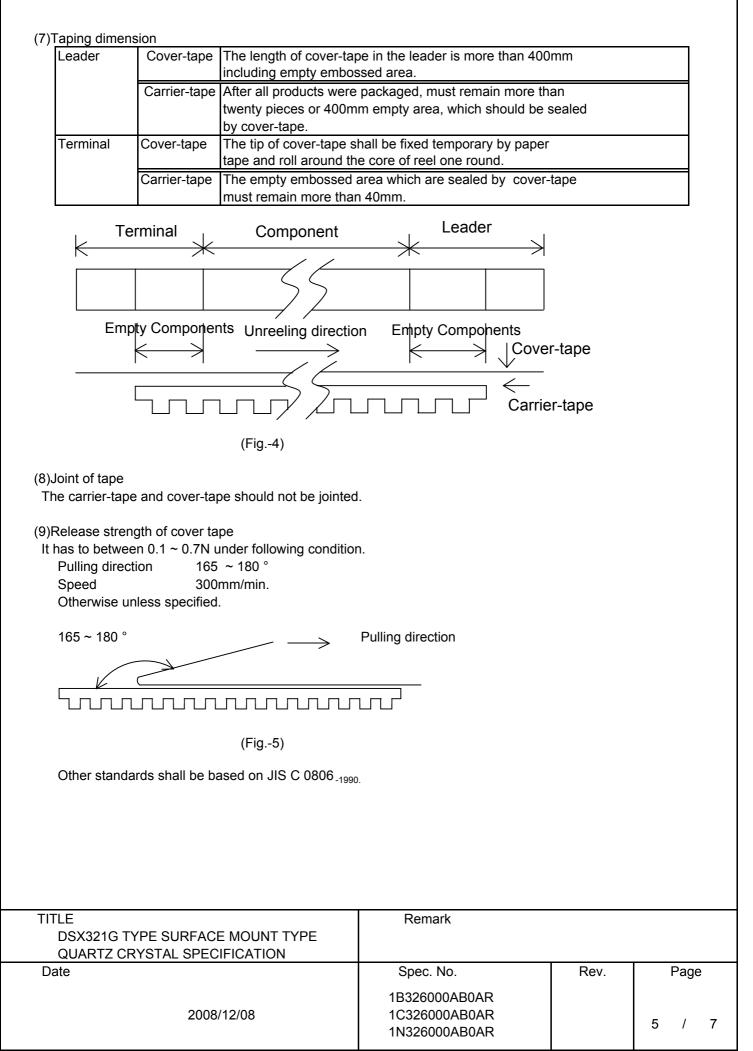
(5)Material of the tape

Таре	Material
Carrier tape	Polystyrene+Carbon
Cover tape	Polyester

(6)Label contents
Type
Our specification No.
Your Part No.
Lot No.
Nominal Frequency
Quantity
Our Company Name
Producting Country

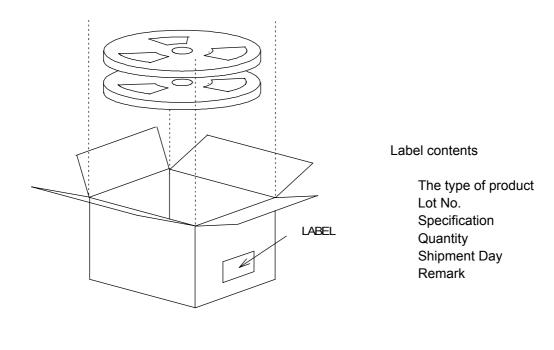
Stick a label on the each reel.

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< PACKING >

(1)STORAGE METHOD



(Fig-6)

(2)BOX SIZE

From lot size packingsize shall be changed.

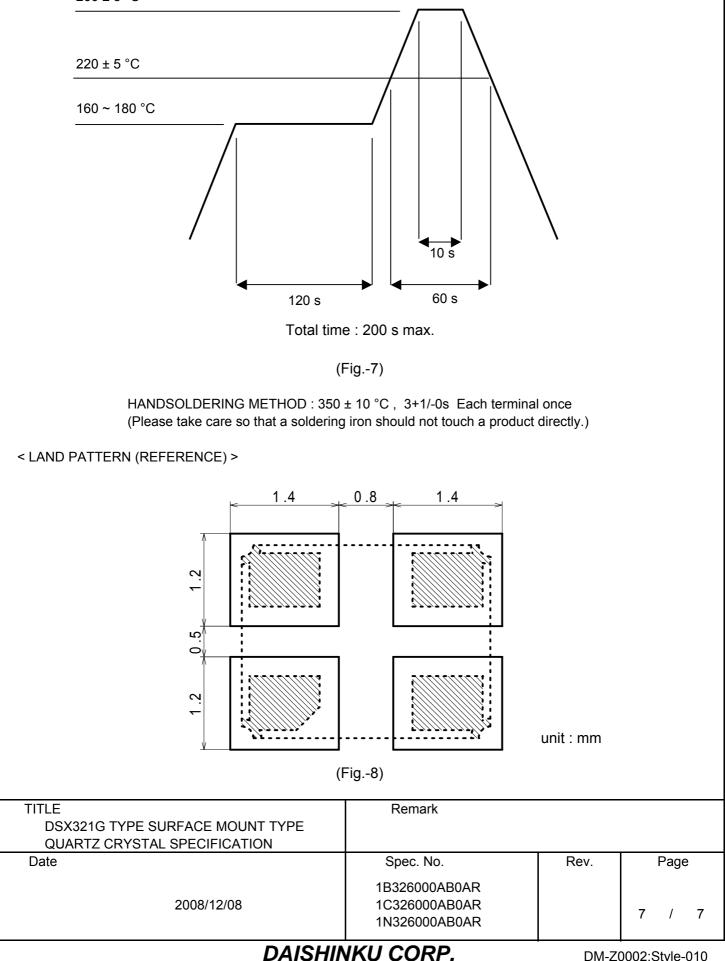
In the upper and lower part and the opening in box it shall be protected products using aircushion sheets.

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< REFLOW CONDITIONS (REFERENCE) >

During the solder reflow process, please complete within following temperature, period. Reflow soldering shall be allowed only 3 times.





DM-Z0002:Style-010

1.MECHANICAL ENDURANCE		
1.1 SHOCK (ACCELERATION) After the following test,parts shall conform 1000m/s ² by 6ms X,Y,Z each axis (6 direc		
1.2 SHOCK (MOUNTING DROP) After the following test,parts shall conform 3cycles(18times) drop from 150 cm heights Further,parts shall be solderd on substrate Substrate materials :	, fixed Aluminum materials(about 100 Glass Epoxy	Dg).
1 cycle :	each 1 times of 6 directions	
1.3 VIBRATION After the following test,parts shall conform	-	
and no abnormal appearance shall be obs		
Frequency of Vibration : Amplitude(p-p) :	Sine waves of 1.5mm or 100m/s	2
	11min	
	X.Y.Z	
Vibration period :	2 h for each axis	
1.4 SEAL Less than 2.0×10 ⁻⁹ Pa m ³ /s. by Helium leal Also, no serial bubble is observed by Fluor		
 After the following test, more than 95% of t solder. 3 ± 0.5 s dip in 245 ± 5 °C solder. (Solder composition : Sn-3Ag-0.5Cu) (Use 1.6 RESISTANCE TO SOLDERING HEAT (F 48 h past at room temperature from followi shall conform specification 3-1-2. perform the attached Reflow conditions to 	rosin type flux for solder.) REFLOW) ng test,parts	
 1.7 RESISTANCE TO SOLDERING HEAT (H 48 h past at room temperature from followi shall conform specification 3-1-2. 350 ± 10°C , 3+1/-0s Each terminal once 		20
1.8 SUBSTRATE BENDING After the following test,parts shall conform and no abnormality shall be observed in ex tightnen and others shall be based on ET-T	specification 3-1-1. kternal appearance and sealing	P.C.B.
Mount the specimen on substrate. Apply the following pressure	reterior de la companya de	
Direction :	see Fig1	1
Speed :	about 1.0 mm/s	45+/-2 45+/-2
Hours : Amount of substrate :	5±1s [*]	(Fig. 1)
TITLE	3 mm max. Remark	(Fig1)
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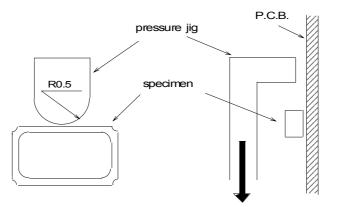
1.9 SHEAR

After the following test,parts shall conform specification 3-1-1. and no abnormality shall be observed in external appearance and sealing tightness and others shall be based on ET-7403 of EIAJ.

Mount the specimen on substrate.

Apply the following pressure

Weight	:	10 N
Hours	:	10 ± 1 s
Direction	:	see Fig2



(Fig.-2)

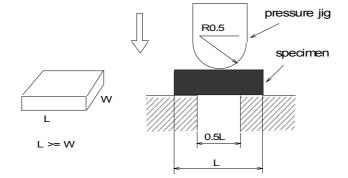
1.10 BODY STRENGTH

After the following test,parts shall conform specification 3-1-1. and no abnormality shall be observed in external appearance and sealing tightness and others shall be based on ET-7403 of EIAJ.

Mount the specimen on substrate.

Apply the following pressure

Weight	:	10 N
Hours	:	10 ± 1 s
Direction	:	see Fig3



(Fig.-3)

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2.ENVIRONMENTAL ENDURANCE

2.1 LOW TEMPERATURE

2 h past at room temperature after following test, parts shall conform specification 3-1-1. 240 h -40 \pm 3 °C.

2.2 HUMIDITY

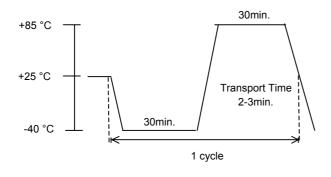
2 h past at room temperature after following test, parts shall conform specification 3-1-1. 240 h +85 \pm 2 °C , relative humidity 85 \pm 5%.

2.3 HIGH TEMPERATURE

2 h past at room temperature after following test, parts shall conform specification 3-1-1. 240 h +85 \pm 2 °C.

2.4 TEMPERATURE CYCLE

2 h past at room temperature after 25 cycles of following test, parts shall conform specification 3-1-1.





3.SPECIFICATION

Frequency Variation and Equivalent Resistance shall be within Table-1 after the test.

	(Table-1)				
	Frequency Variation Equivalent Resistance				
3-1-1	±2 ppm	± 15 % or 2 Ω max. (Use larger specification)			
3-1-2	±5 ppm	± 20 % or 3 Ω max. (Use larger specification)			
3-1-3	±10 ppm	±20 % or 3 Ω max. (Use larger specification)			

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[DSX321G SERIES , IN USE]

1.SOLDERING

Please perform the attached Reflow conditions to reference within 3 times.

2.MOUNT

Crystal products are designed to be compatible with automatic mounting. Be sure to have a mounting test in advance by using the actual mounting machine and check that the characteristics of the products are not damaged by the automatic mounting.

In the process where the boad is warped, such as board separation process, be careful that the warping does not influence the characteristics and soldering of crystal products.

Since mounting by Ultrasonic welding and processing have a possibility of an excessive vibration spreading inside a crystal resonator and becoming the cause of characteristic deterioration and not oscillating, it does not recommend.

3.WASHING

About use of the washing liquid of a basin system, an alcoholic system, and a chlorofluorocarbon-replacing material system, it is checking that it is satisfactory. However please consult in advance about other washing liquid. Although the check about ultrasonic washing is performed, since it is an examination with a simple substance, the check for the second time by the use state is recommended.

4.THE CAUTIONS ON USE

The piece of crystal it is processed very smaller than the conventional thing inside DSX321G series crystal unit may be damaged, if excessive excitation electric power is applied. Please use it below with the value specified on a catalog and specifications.

Please use it below with the value specified on a catalog and specifications.

Please refrain from forming patterns under crystal resonators since there is

a possibility to cause crack in base.

If the temperature is higher than 280 °C, there is a possibility for the sealing glass to remelt. Avoid using the product at temperature higher than specified.

5.HANDLING OF A PRODUCT

DSX321G series has sufficient intensity to fall and vibration. However when too much shock is added according to a certain cause, the use after a characteristic check is recommended.

6.STORAGE

Since the soldering nature of a terminal may be degraded, please avoid storage in high temperature and a humid place. Please keep it in the place which direct rays do not hit and dew condensation does not generate.

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2008-1640 REVISION RECORD

Rev.No	Date	Reason	Contents	Approved	Checked	Drawn
-	2008/12/08		The first edition.	T. Miura	H. Matsuda	M.Shikai